Crystal synthesis of a new cesium aluminosilicate, CsAlSi₅O₁₂

JUN ITO

The James Franck Institute, The University of Chicago 5640 South Ellis Avenue, Chicago, Illinois 60637

Abstract

Small single crystals of a new cesium aluminosilicate, ideally $CsAlSi_5O_{12}$, have been grown by slow cooling of the melt containing Ba-,Cs-vanadate flux (1420-750°C). The compound is orthorhombic, with space group *Bbm2*; a = 13.785(1), b = 16.727(1), c = 5.0130(5); V =1155.9(1) Å³; Z = 4. Electron microprobe and atomic absorption chemical analysis gave SiO₂ 65.0, Al₂O₃ 10.2, Cs₂O 25.0, BaO 0.16, and Fe₂O₃ 0.06 wt percent. The formula computed on the basis of 12 oxygen atoms per unit formula gave Ba_{0.005} Cs_{0.834} Fe³⁺_{0.004} Al_{0.939} Si_{5.084} O₁₂. There may be some partial solid solubility of BaAl₂Si₄O₁₂ (hypothetical) in CsAlSi₅O₁₂.

Introduction

During the course of the investigation of flux growth of single crystals of the feldspar type structure (Grove and Ito, 1973), a new anhydrous cesium aluminosilicate, having the ideal formula $CsAlSi_5O_{12}$, was obtained by a slow cooling of the clear melt containing a large amount of Ba-,Cs-vanadate flux. A brief account of the method used and the crystal data that have been obtained is presented.

Synthesis

Small crystals of CsAlSi₅O₁₂ have been synthesized by spontaneous nucleation from the clear melt. Initial charge of the melt was: reagent grade BaCO₃ 4.00 g, Cs₂CO₃ 4.91 g, H₂SiO₃ 3.60 g, Al₂O₃ 0.500 g, Fe₂O₃ 33.3 mg, and V₂O₅ 10 g. The charge was placed in a platinum crucible of 50 ml capacity which was gradually heated up to 1360°C, and kept for 48 hours in a muffle furnace with silicon carbide heating elements. The melt was then brought up to 1420°C to ensure the complete dissolution of the solid, then cooled at 2°C per hour using an on-off program-controller. The heating was terminated at 750°C; then the furnace was brought to room temperature.

The crystals apparently grew from a few nuclei either floating on the surface of the melt or adhering to the upper wall of the crucible, since a temperature gradient was maintained throughout the experiment with the bottom of the crucible hotter than the top. Countless thin platy crystals elongated parallel to (100) with well-developed (010) grew into the melt, thus forming several clusters of radially grown crystals. Separation of the crystals from the flux was easily done by soaking the melt in a hot dilute NaOH (5%) solution followed by rapid rinsing with a dilute cold HCl (5%) solution. The yield was approximately 1.0 g of the single phase crystalline CsAlSi₅O₁₂.

Results of characterization

X-ray precession photographs, using MoK α radiation, taken on the three crystallographic axes, showed the presence of *mmm* symmetry with the following extinction criteria: 0kl, k = 2n, k + l = 2n and hkl, h + l = 2n. The space group was determined by Dr. T. Araki, using a four circle X-ray diffractometer, as orthorhombic *Bbm2*. Unit-cell dimensions obtained from the indexed powder data (Table 1) collected from the fine-grained material (CuK α_1 radiation with Si standard) were refined using a computer program written by Appleman and Evans (1973). These are a = 13.785(1), b = 16.727(1), c = 5.0130(5) Å; V = 1155.9(1); Z = 4.

The only known Cs-aluminosilicate, pollucite, has a framework structure with 4-, 6-, and 8-membered loops of tetrahedra and resembles the analcite structure NaAlSi₂O₆·H₂O (Náray-Szabó, 1938; Beger, 1969). However, the structure of the new cesium aluminosilicate consists of a single layer framework containing 5-membered rings of the Al and Si tetrahedra (T. Araki, private communication). Another example of a single layer framework is found in the mordenitetype structure (Meier, 1961).

Electron microprobe and atomic absorption analysis of the flux-grown crystals gave: $SiO_2 = 65.0$, $Al_2O_3 = 10.2$, $Fe_2O_3 = 0.06$, $Cs_2O = 25.0$, BaO = 0.16. Total 100.42 wt percent. Analyzed Tanco pollucite

h	k	ł	I/lo	d(calc)	d(obs)	h	k	I	1/lo	d(calc)	d(obs)
1 1 2 0 1	0 1 3 4 2	1 1 0 0 1	3 2 2 5 30	4.711 4.535 4.335 4.182 4.105	4.713 4.530 4.333 4.178 4.108	6 0 5 2 4	3 8 4 4 1	0 0 1 2 2	15 10 5 5	2.124 2.091 2.092 2.052 2.012	2.124 2.092 2.052 2.013
1 2 4 3 4	3 4 0 1	1 0 0 1 0	100 60 20 10 40	3.598 3.575 3.446 3.387 3.375	3.597 3.577 3.447 3.386 3.375	5 3 2 4 6	5 7 5 3 5	1 1 2 2 0	3 5 3 5 8	1.958 1.952 1.926 1.905 1.894	1.958 1.952 1.926 1.905 1.894
34324	1 2 2 5 3	1 0 1 0	20 10 8 25 15	3.320 3.186 3.140 3.010 2.931	3.319 3.185 3.140 3.010 2.932	0 7 5 4 7	6 0 6 4 2	2 1 1 2 1	2 3 5 5	1.864 1.833 1.826 1.824 1.790	1.863 1.832 1.826 1.823 1.791
3 0 1 4 3	3 6 5 4 4	1 0 1 0 1	10 15 15 3 5	2.895 2.788 2.728 2.659 2.632	2.896 2.787 2.728 2.658 2.632	3 7 4 1 5	8 3 5 9 7	1 1 2 1 1	5 5 5 5 3	1.779 1.741 1.734 1.729 1.699	1.779 1.741 1.735 1.729 1.699
2 0 5 4 1	6 0 0 5 6	0 2 1 0 1	15 5 5 10	2.584 2.506 2.415 2.400 2.399	2.584 2.506 2.415 2.400	6 8 6 2 0	0 2 1 7	2 0 2 2 0	3 5 5 8 10	1.694 1.688 1.685 1.677 1.673	1.695 1.687 1.684 1.677 1.673
2 5 6 2 2	0 2 1 2 7	2 1 0 2 0	5 5 5 10	2.355 2.321 2.276 2.267 2.258	2.355 2.321 2.278 2.268 2.258	4 2 6 1 5	9 10 3 3 8	0 2 3 1	5 8 5 5 5	1.636 1.625 1.620 1.590 1.581	1.635 1.624 1.621 1.590 1.581
2 4 3 0 1	3 6 4 7	2 0 1 2 1	8 8 15	2.170 2.167 2.153 2.150 2.131	2.169 2.153 2.130	1	10		15	1.576	1.576

TABLE 1. X-Ray Powder Data for a New Cesium Aluminosilicate, $CsAlSi_5O_{12}^*$

*Diffractometer with $Cu\underline{K}\alpha_1$ radiation with Si standard. Refined unit-cell dimensions are a = 13.785(1), <u>b</u> = 16.727(1), <u>c</u> = 5.0130(5) Å; <u>V</u> = 1155.9(1) Å³; <u>Z</u> = 4.

 $\underline{c} = 5.0130(5) \text{ A}; \underline{v} = 1155.9(1) \text{ A}^{\circ}$ Space group orthorhombic <u>Bbm2</u>.

(U39-95.5), kindly supplied by Dr. P. Czerny of the University of Manitoba, was used as a probe standard. Spectrographic analysis of the hand-picked sample showed V as a significant impurity and a trace quantity of Ti, Cr, and Ca. Atomic absorption analysis gave $V_2O_5 = 0.4$ wt percent in the bulk sample, but it is not certain whether it is incorporated in the crystal structure or is a mere inclusion, since a large number of vanadate flux-grown crystals are known to contain vanadium oxide as an essential component as well as an inclusion (Flanigen et al, 1969; Grandin de L'Eprevier, 1972). The amount of BaO incorporated into the crystal was low, considering the high BaO content in the melt. The above analysis without V_2O_5 was computed on the basis of 12 oxygens according to the structure analysis. The formula is thus given as:

Ba0.005 Cs0.834 Alo.939 Si5.084 O12

A small solid solubility of the hypothetical $BaAl_2Si_4O_{12}$ was indicated by the analysis of the Babearing crystal (BaO 1.76 wt%). This was obtained from a Ba-rich run which resulted in a large amount of celsian crystals (Cs₂O 0.72 wt%). The extent of solid solution may be limited by the large difference in cation size between Cs¹⁺ and Ba²⁺. Specific gravity determined by flotation in a mixture of methylene iodide and carbon tetrachloride was found to be 2.709 (20°C) which agrees well with the calculated value of 2.710.

The crystals of the new Cs-aluminosilicate melt at a temperature above 1420°C; however, slow cooling of the resulting clear melt from 1460° to 1360°C failed to nucleate crystals. Clear glass was obtained. Therefore, direct growth from the pure liquid may be difficult.

Large single crystals, up to 5 mm in length, of Cscontaining celsian (monoclinic C2/m and I2/c) and hexacelsian (hexagonal *P6mm*) have been successfully grown in the Ba-rich (Cs-poor) range using similar conditions and technique. Detailed structure work has been completed by Dana Griffen at Virginia Polytechnic Institute and State University.

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